TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (U-MOSVI-H)

# **TPC8036-H**

High Efficiency DC-DC Converter Applications Notebook PC Applications Portable Equipment Applications

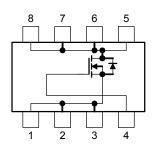
- Small footprint due to a small and thin package
- High-speed switching
- Small gate charge: Qsw = 13 nC (typ.)
- Low drain-source ON-resistance: RDS (ON) =  $3.1 \text{ m}\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 64 \text{ S (typ.)}$
- Low leakage current:  $I_{DSS} = 10 \mu A \text{ (max) (V}_{DS} = 30 \text{ V)}$
- Enhancement mode:  $V_{th} = 1.3 \text{ to } 2.3 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 0.5 \text{ mA})$

#### Absolute Maximum Ratings (Ta = 25°C)

Characte	eristic	Symbol	Rating	Unit
Drain-source voltage		$V_{DSS}$	30	V
Drain-gate voltage (R	GS = 20 kΩ)	$V_{DGR}$	30	V
Gate-source voltage		$V_{GSS}$	±20	V
Drain current	DC (Note 1)	ΙD	18	Α
Diam cancil	Pulsed (Note 1)	$I_{DP}$	72	Α
Drain power dissipation	on $(t = 10 s)$ (Note 2a)	$P_{D}$	1.9	W
Drain power dissipation	on $(t = 10 s)$ (Note 2b)	P <sub>D</sub>	1.0	W
Single pulse avalanch	ne energy (Note 3)	E <sub>AS</sub>	211	mJ
Avalanche current		I <sub>AR</sub>	18	Α
Repetitive avalanche	energy Note 2a) (Note 4)	E <sub>AR</sub>	0.13	mJ
Channel temperature		T <sub>ch</sub>	150	°C
Storage temperature	range	T <sub>stg</sub>	-55 to 150	°C

Weight: 0.085 g (typ.)

### **Circuit Configuration**



Note: For Notes 1 to 4, refer to the next page.

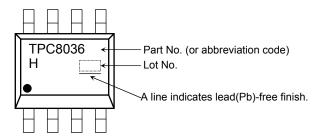
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.

#### **Thermal Characteristics**

Characteristic	Symbol	Max	Unit
Thermal resistance, channel to ambient $(t=10 \; s) \eqno(Note \; 2a)$	R <sub>th (ch-a)</sub>	65.8	°C/W
Thermal resistance, channel to ambient $(t=10 \; s) \eqno(Note \; 2b)$	R <sub>th (ch-a)</sub>	125	°C/W

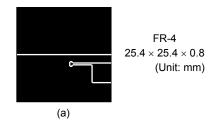
#### Marking (Note 5)

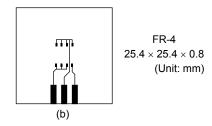


Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)



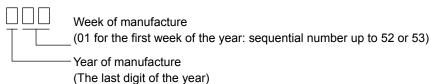


Note 3:  $V_{DD}=24~V,~T_{ch}=25^{\circ}C$  (initial),  $L=500~\mu H,~R_{G}=25~\Omega,~I_{AR}=18~A$ 

Note 4: Repetitive rating: pulse width limited by maximum channel temperature

Note 5: • on lower left of the marking indicates Pin 1.

\* Weekly code: (Three digits)



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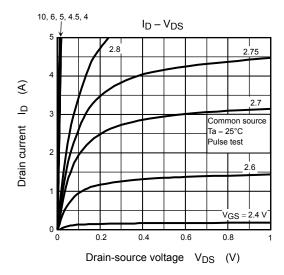
## **Electrical Characteristics (Ta = 25°C)**

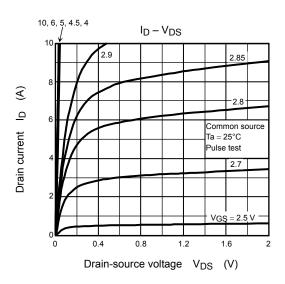
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	nA
Drain cut-OFF cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	_	_	10	μА
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10$ mA, $V_{GS} = 0$ V	30	_	_	V
Diain-source brea	akdown voltage	V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	- 3.7 5.1 - 3.1 4.5 32 64 - - 3500 4600 - 230 370 - 690 -		_	V
Gate threshold vo	oltage	V <sub>th</sub>	$V_{DS} = 10 \text{ V}, I_D = 0.5 \text{ mA}$	1.3	_	2.3	V
Drain-source ON	resistance	Pro (ON)	$V_{GS} = 4.5 \text{ V}, I_D = 9 \text{ A}$		3.7	5.1	m0
Dialii-source ON	-resistance	R <sub>DS</sub> (ON)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 9 A	—     —     10       30     —     —       15     —     —       1.3     —     2.3       —     3.7     5.1       —     3.1     4.5       32     64     —       —     3500     4600       —     230     370       —     690     —       —     1.0     1.5       —     4.5     —       —     14     —       —     7.4     —       —     46     —	mΩ		
Forward transfer	admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 9 A	32	64	_	S
Input capacitance		C <sub>iss</sub>		_	3500	4600	pF
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	230	370	
Output capacitance		Coss		_	690	_	
Gate resistance		rg	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	-   1.0   1.5		Ω
	Rise time	t <sub>r</sub>	V <sub>GS</sub> 0 V	_	4.5	_	ns
Switching time	Turn-on time	t <sub>on</sub>		_	14	_	
	Fall time	t <sub>f</sub>		_	7.4	_	
	Turn-off time	t <sub>off</sub>	V <sub>DD</sub> ≈ 15 V Duty ≤ 1%, t <sub>W</sub> = 10 μs	_	46	_	
Total gate charge	Total gate charge		$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}$		49	_	
(gate-source plus	gate-drain)	Qg	$V_{DD} \approx 24 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 18 \text{ A}$			_	
Gate-source charge 1		Q <sub>gs1</sub>		_	10	_	nC
Gate-drain ("miller") charge		Q <sub>gd</sub>	$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}$		7.7	_	
Gate switch char	ge	Q <sub>SW</sub>	]	_	13	_	

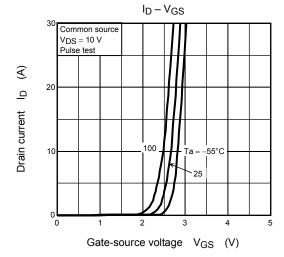
## Source-Drain Ratings and Characteristics (Ta = 25°C)

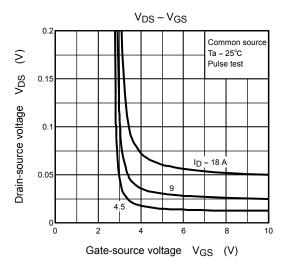
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Drain reverse current	Pulse	(Note 1)	I <sub>DRP</sub>	_	_	_	72	Α
Forward voltage (diode)			$V_{DSF}$	I <sub>DR</sub> = 18 A, V <sub>GS</sub> = 0 V	_	_	-1.2	V

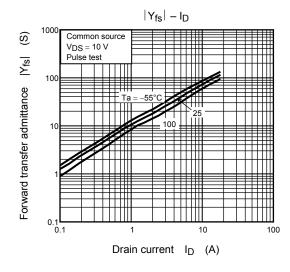
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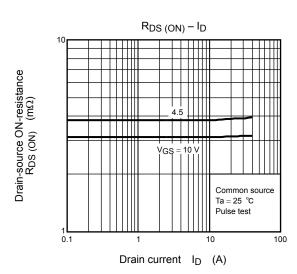




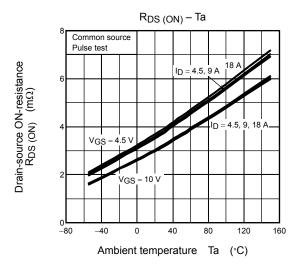


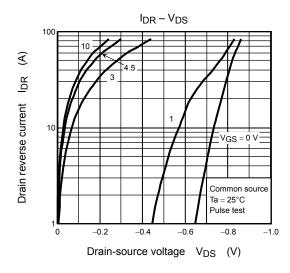


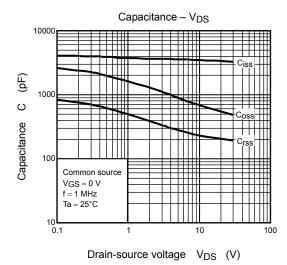


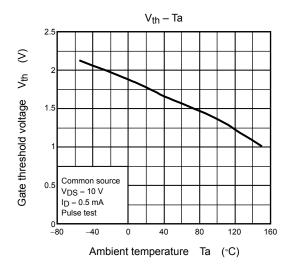


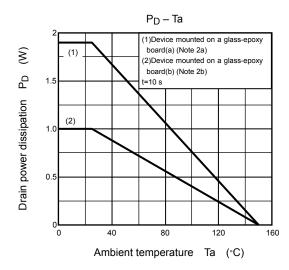
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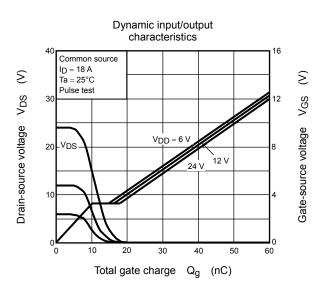


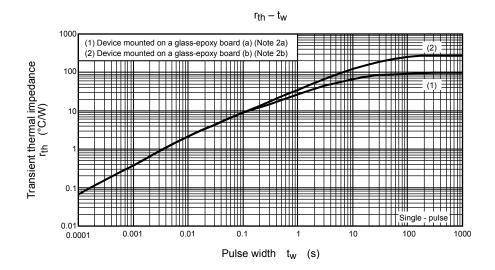


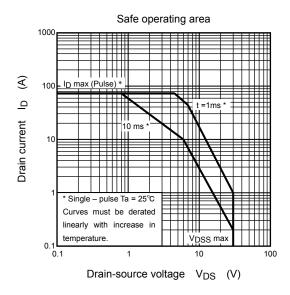












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